

Search Notes

Application/Control No.

10/071,645

Examiner

Jon M. Lockard

Applicant(s)/Patent under
Reexamination

BIHAIN ET AL.

Art Unit

1647

SEARCHED

Class	Subclass	Date	Examiner
530	350	7/30/2004	JML
514	12	7/30/2004	JML
435	7.1	7/30/2004	JML
435	69.1	7/30/2004	JML
Updated		4/24/2005	JML

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC Sequence Search of Commercial and Patent Databases: See Attached Search Report	5/11/2004	JML
STIC Sequence Search of SEQ ID NO:1 Against Commercial and Patent Databases, Word Size = 20: See Attached Search Report.	7/7/2004	JML
East Search: text and Inventor's Name Search. See Attached Search Report.	7/30/2004	JML
PALM: Inventor's Name Search.	7/30/2004	JML
Updated	4/24/2005	JML
STIC Sequence Search of Commercial and Patent Databases: See Attached Search Report	3/30/2005	JML